# **Single Supply Analog Switch**

The MC74VHC1GT66 is an advanced high speed CMOS bilateral analog switch fabricated with silicon gate CMOS technology. It achieves high speed propagation delays and low ON resistances while maintaining low power dissipation. This bilateral switch controls analog and digital voltages that may vary across the full power–supply range (from V<sub>CC</sub> to GND).

The MC74VHC1GT66 is compatible in function to a single gate of the very High Speed CMOS MC74VHCT4066. The device has been designed so that the ON resistances (R<sub>ON</sub>) are much lower and more linear over input voltage.

The ON/OFF Control input is compatible with TTL-type input thresholds allowing the device to be used as a logic-level translator from 3.0 V CMOS logic to 5.0 V CMOS logic or from 1.8 V CMOS logic to 3.0 V CMOS logic while operating at the high-voltage power supply. The input protection circuitry on this device allows overvoltage tolerance on the input, which provides protection when voltages of up to 7 V are applied, regardless of the supply voltage. This allows the MC74VHC1GT66 to be used to interface 5 V circuits to 3 V circuits.

- High Speed: tpD = 20 ns (Typ) at  $V_{CC} = 5 \text{ V}$
- Low Power Dissipation:  $I_{CC} = 1 \mu A \text{ (Max)}$  at  $T_A = 25^{\circ}C$
- Diode Protection Provided on Inputs and Outputs
- Improved Linearity and Lower ON Resistance over Input Voltage
- On/Off Control Input Has OVT
- Chip Complexity: FETs = 11; Equivalent Gates = 3

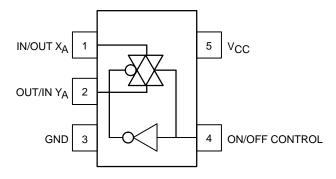


Figure 1. Pinout

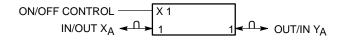


Figure 2. Logic Symbol



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### MARKING DIAGRAMS



SC70-5/SC-88A/SOT-353 DF SUFFIX CASE 419A





SOT23-5/TSOP-5/SC59-5 DT SUFFIX CASE 483



d = Date Code

	PIN ASSIGNMENT						
1	IN/OUT X <sub>A</sub>						
2 OUT/IN Y <sub>A</sub>							
3	GND						
4	ON/OFF CONTROL						
5	VCC						

### **FUNCTION TABLE**

State of Analog Switch		
Off		
On		

### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

### **MAXIMUM RATINGS**

Symbol	Characte	eristics	Value	Unit
Vcc	DC Supply Voltage	-0.5 to +7.0	V	
VIN	DC Input Voltage		-0.5 to +7.0	V
VIS	Analog Output Voltage		-0.5 to 7.0	V
ΙK	Input Diode Current		-20	mA
ICC	DC Supply Current, V <sub>CC</sub> and GND		+25	mA
TSTG	Storage Temperature Range	-65 to +150	°C	
TL	Lead Temperature, 1 mm from Case for	10 Seconds	260	°C
TJ	Junction Temperature Under Bias		+ 150	°C
θЈА	Thermal Resistance	SC70-5/SC-88A/SOT-353 (Note 1) SOT23-5/TSOP-5/SC59-5	350 230	°C/W
P <sub>D</sub>	Power Dissipation in Still Air at 85°C	SC70-5/SC-88A/SOT-353 SOT23-5/TSOP-5/SC59-5	150 200	mW
MSL	Moisture Sensitivity		Level 1	
F <sub>R</sub>	Flammability Rating	Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in	
VESD	ESD Withstand Voltage	Human Body Model (Note 2) Machine Model (Note 3) Charged Device Model (Note 4)	> 2000 > 200 N/A	V
ILATCH-UP	Latch-Up Performance Above V	CC and Below GND at 125°C (Note 5)	±500	mA

Maximum Ratings are those values beyond which damage to the device may occur. Exposure to these conditions or conditions beyond those indicated may adversely affect device reliability. Functional operation under absolute—maximum—rated conditions is not implied. Functional operation should be restricted to the Recommended Operating Conditions.

- 1. Measured with minimum pad spacing on an FR4 board, using 10 mm-by-1 inch, 2-ounce copper trace with no air flow.
- 2. Tested to EIA/JESD22-A114-A.
- 3. Tested to EIA/JESD22-A115-A.
- 4. Tested to JESD22-C101-A.
- 5. Tested to EIA/JESD78.

### RECOMMENDED OPERATING CONDITIONS

Symbol	Characteristics	Min	Max	Unit	
VCC	DC Supply Voltage	2.0	5.5	V	
V <sub>IN</sub>	Digital Input Voltage	GND	5.5	V	
VIS	Analog Input Voltage		GND	Vcc	V
TA	Operating Temperature Range		<b>-</b> 55	+125	°C
t <sub>r</sub> , t <sub>f</sub>	Input Rise and Fall Time	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ $V_{CC} = 5.0 \text{ V} \pm 0.5 \text{ V}$	0 0	100 20	ns/V

# DEVICE JUNCTION TEMPERATURE VERSUS TIME TO 0.1% BOND FAILURES

Junction Temperature °C	Time, Hours	Time, Years
80	1,032,200	117.8
90	419,300	47.9
100	178,700	20.4
110	79,600	9.4
120	37,000	4.2
130	17,800	2.0
140	8,900	1.0

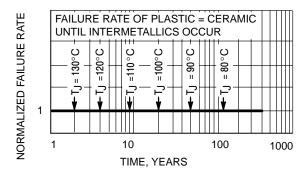


Figure 3. Failure Rate vs. Time Junction Temperature

### DC ELECTRICAL CHARACTERISTICS

			VCC	T <sub>A</sub> = 25°C		T <sub>A</sub> ≤	85°C	$-55$ °C ≤ $T_A$ ≤ 125°C		
Symbol	Parameter	Test Conditions	(V)	Min	Max	Min	Max	Min	Max	Unit
VIH	Minimum High–Level Input Voltage ON/OFF Control Input	R <sub>ON</sub> = Per Spec	3.0 4.5 5.5	1.2 2.0 2.0		1.2 2.0 2.0		1.2 2.0 2.0		V
V <sub>IL</sub>	Maximum Low–Level Input Voltage ON/OFF Control Input	R <sub>ON</sub> = Per Spec	3.0 4.5 5.5		0.53 0.8 0.8		0.53 0.8 0.8		0.53 0.8 0.8	V
lIN	Maximum Input Leakage Current ON/OFF Control Input	$V_{IN} = V_{CC}$ or GND	0 to 5.5		±0.1		±1.0		±1.0	μА
ICC	Maximum Quiescent Supply Current	V <sub>IN</sub> = V <sub>CC</sub> or GND V <sub>IO</sub> = 0 V	5.5		1.0		20		40	μΑ
ICCT	Quiescent Supply Current	ON/OFF Control at 3.4 V	5.5		1.35		1.5		1.65	mA
RON	Maximum "ON" Resistance	$V_{IN} = V_{IH}$ $V_{IS} = V_{CC}$ or GND $ I_{IS}  \le 10$ mA (Figure 4.)	3.0 4.5 5.5		60 45 40		70 50 45		100 60 55	Ω
OFF	Maximum Off–Channel Leakage Current	V <sub>IN</sub> = V <sub>IL</sub> V <sub>IS</sub> = V <sub>CC</sub> or GND Switch Off (Figure 5.)	5.5		0.1		0.5		1.0	μА

### AC ELECTRICAL CHARACTERISTICS $C_{load}$ = 50 pF, Input $t_f/t_f$ = 3.0 ns

			vcc	Т	A = 25°	С	T <sub>A</sub> ≤	85°C	-55°C ≤ T	A ≤ 125°C	
Symbol	Parameter	Test Conditions	(V)	Min	Тур	Max	Min	Max	Min	Max	Unit
tPLH, tPHL	Maximum Propagation Delay, Input X to Y	Y <sub>A</sub> = Open (Figure 14.)	2.0 3.0 4.5 5.5		1 0.6 0.6 0.6	5 2 1 1		6 3 1 1		7 4 2 1	ns
tPLZ, tPHZ	Maximum Propagation Delay, ON/OFF Control to Analog Output	$R_L$ = 1000 $Ω$ (Figure 15.)	2.0 3.0 4.5 5.5		32 28 24 20	40 35 30 25		45 40 35 30		50 45 40 35	ns
tPZL, tPZH	Maximum Propagation Delay, ON/OFF Control to Analog Output	R <sub>L</sub> = 1000 Ω (Figure 15.)	2.0 3.0 4.5 5.5		32 28 24 20	40 35 30 25		45 40 35 30		50 45 40 35	ns
C <sub>IN</sub>	Maximum Input	ON/OFF Control Input	0.0		3	10		10		10	pF
	Capacitance	Control Input = GND Analog I/O Feedthrough	5.0		4 4	10 10		10 10		10 10	

		Typical @ 25°C, V <sub>CC</sub> = 5.0 V	
C <sub>PD</sub>	Power Dissipation Capacitance (Note 6)	18	pF

<sup>6.</sup> CpD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation:  $I_{CC(OPR)} = C_{PD} \cdot V_{CC} \cdot f_{in} + I_{CC}$ . CpD is used to determine the no–load dynamic power consumption;  $P_D = C_{PD} \cdot V_{CC}^2 \cdot f_{in} + I_{CC} \cdot V_{CC}$ .

### ADDITIONAL APPLICATION CHARACTERISTICS (Voltages Referenced to GND Unless Noted)

Symbol	Parameter	Test Conditions	vcc	Limit 25°C	Unit
BW	Maximum On–Channel Bandwidth or Minimum Frequency Response (Figure 10.)	$f_{in}$ = 1 MHz Sine Wave Adjust $f_{in}$ voltage to obtain 0 dBm at VOS Increase $f_{in}$ = frequency until dB meter reads –3 dB R <sub>L</sub> = 50 $\Omega$ , C <sub>L</sub> = 10 pF	3.0 4.5 5.5	150 175 180	MHz
ISO <sub>off</sub>	Off–Channel Feedthrough Isolation (Figure 11.)	$f_{\text{in}}$ = Sine Wave Adjust $f_{\text{in}}$ voltage to obtain 0 dBm at V <sub>IS</sub> $f_{\text{in}}$ = 10 kHz, R <sub>L</sub> = 600 $\Omega$ , C <sub>L</sub> = 50 pF	3.0 4.5 5.5	-80 -80 -80	dB
NOISE <sub>feed</sub>	Feedthrough Noise Control to Switch (Figure 12.)	$V_{in} \le 1$ MHz Square Wave $(t_f = t_f = 2ns)$ $R_L = 600 \ \Omega, \ C_L = 50 \ pF$	3.0 4.5 5.5	45 60 130	mVpp
THD	Total Harmonic Distortion (Figure 13.)	$f_{\text{In}} = 1 \text{ kHz}, R_{\text{L}} = 10 \text{ k}\Omega, C_{\text{L}} = 50 \text{ pF}$ $\text{THD} = \text{THD}_{\text{Measured}} - \text{THD}_{\text{Source}}$ $\text{V}_{\text{IS}} = 3.0 \text{ Vpp sine wave}$ $\text{V}_{\text{IS}} = 5.0 \text{ Vpp sine wave}$	3.3 5.5	0.30 0.15	%

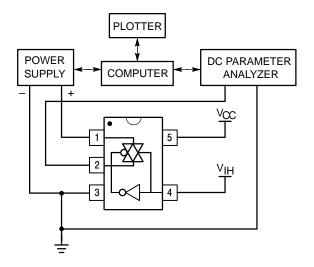


Figure 4. On Resistance Test Set-Up

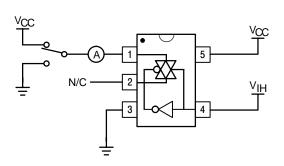


Figure 6. Maximum On–Channel Leakage Current Test Set–Up

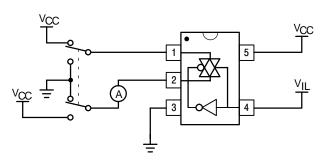


Figure 5. Maximum Off-Channel Leakage Current Test Set-Up

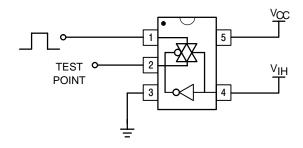


Figure 7. Propagation Delay Test Set-Up

Switch to Position 2 when testing  $t_{PLZ}$  and  $t_{PZL}$  Switch to Position 1 when testing  $t_{PHZ}$  and  $t_{PZH}$ 

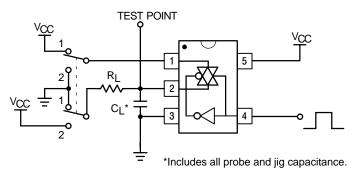


Figure 8. Propagation Delay Output Enable/Disable
Test Set-Up

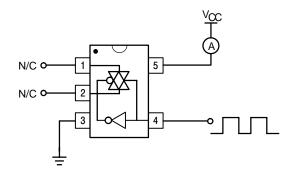
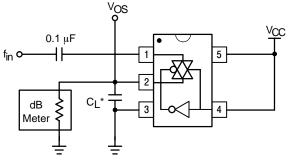


Figure 9. Power Dissipation Capacitance
Test Set-Up



\*Includes all probe and jig capacitance.

Figure 10. Maximum On-Channel Bandwidth
Test Set-Up

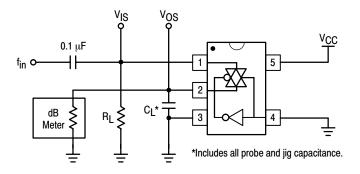


Figure 11. Off-Channel Feedthrough Isolation Test Set-Up

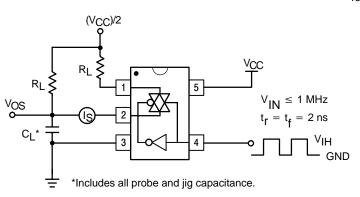


Figure 12. Feedthrough Noise, ON/OFF Control to Analog Out, Test Set-Up

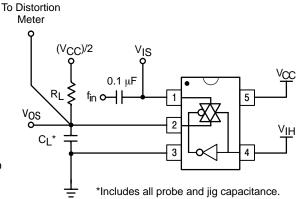


Figure 13. Total Harmonic Distortion Test Set-Up

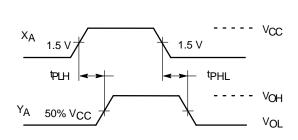


Figure 14. Propagation Delay, Analog In to Analog Out Waveforms

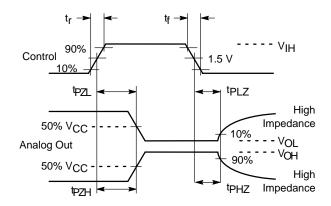


Figure 15. Propagation Delay, ON/OFF Control

### **DEVICE ORDERING INFORMATION**

			Device Nome					
Device Order Number	Circuit Indicator	Temp Range Identifier	Technology	Device Function	Package Suffix	Tape & Reel Suffix	Package Type (Name/SOT#/ Common Name)	Tape and Reel Size
MC74VHC1GT66DFT1	МС	74	VHC1G	T66	DF	T1	SC70-5/SC-88A/ SOT-353	178 mm (7") 3000 Unit
MC74VHC1GT66DFT2	МС	74	VHC1G	T66	DF	T2	SC70-5/SC-88A/ SOT-353	178 mm (7") 3000 Unit
MC74VHC1GT66DTT1	MC	74	VHC1G	T66	DT	T1	SOT23-5/TSOP-5/ SC59-5	178 mm (7") 3000 Unit

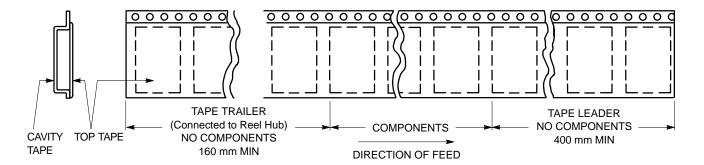


Figure 16. Tape Ends for Finished Goods

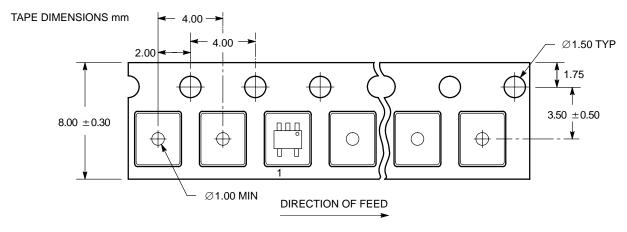


Figure 17. SC-70-5/SC-88A/SOT-353 DFT1 Reel Configuration/Orientation

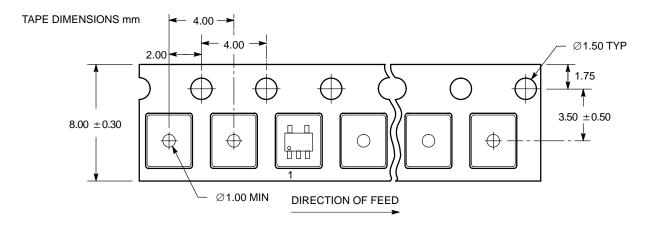


Figure 18. SC-70/SC-88A/SOT-353 DFT2 and SOT23-5/TSOP-5/SC59-5 DTT1 Reel Configuration/Orientation

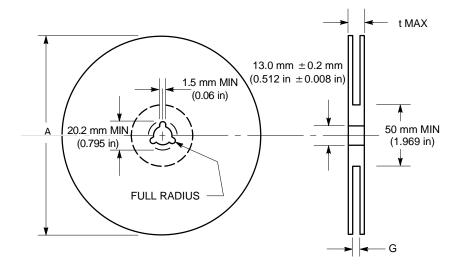


Figure 19. Reel Dimensions

### **REEL DIMENSIONS**

Tape Size	T and R Suffix	A Max	G	t Max
8 mm	T1, T2	178 mm (7 in)	8.4 mm, + 1.5 mm, -0.0 (0.33 in + 0.059 in, -0.00)	14.4 mm (0.56 in)

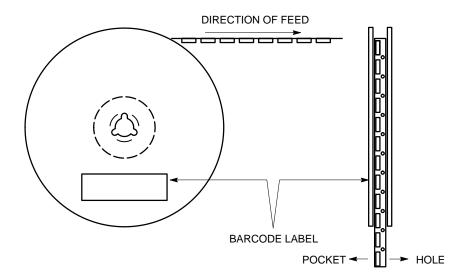
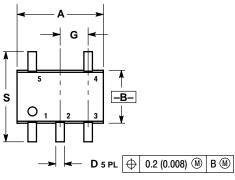


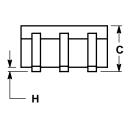
Figure 20. Reel Winding Direction

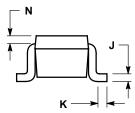
### **PACKAGE DIMENSIONS**

### SC70-5/SC-88A/SOT-353 **DF SUFFIX**

5-LEAD PACKAGE CASE 419A-02 ISSUE F

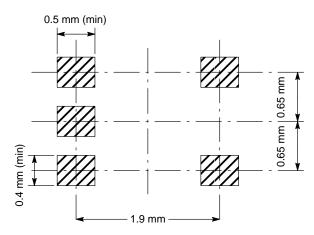






- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.
  3. 419A-01 OBSOLETE. NEW STANDARD 419A-02.

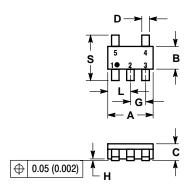
	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.071	0.087	1.80	2.20	
В	0.045	0.053	1.15	1.35	
C	0.031	0.043	0.80	1.10	
D	0.004	0.012	0.10	0.30	
G	0.026	BSC	0.65 BSC		
Н		0.004		0.10	
J	0.004	0.010	0.10	0.25	
K	0.004	0.012	0.10	0.30	
N	0.008 REF		0.20 REF		
S	0.079	0.087	2.00	2.20	

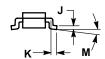


### **PACKAGE DIMENSIONS**

### SOT23-5/TSOP-5/SC59-5 **DT SUFFIX**

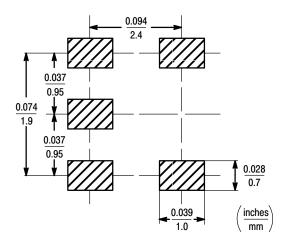
5-LEAD PACKAGE CASE 483-01 ISSUE B





- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL

	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
Α	2.90	3.10	0.1142	0.1220
В	1.30	1.70	0.0512	0.0669
С	0.90	1.10	0.0354	0.0433
D	0.25	0.50	0.0098	0.0197
G	0.85	1.05	0.0335	0.0413
Н	0.013	0.100	0.0005	0.0040
J	0.10	0.26	0.0040	0.0102
K	0.20	0.60	0.0079	0.0236
L	1.25	1.55	0.0493	0.0610
M	0 °	10°	0°	10°
S	2 50	3.00	0.0985	0.1181



# **Notes**

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